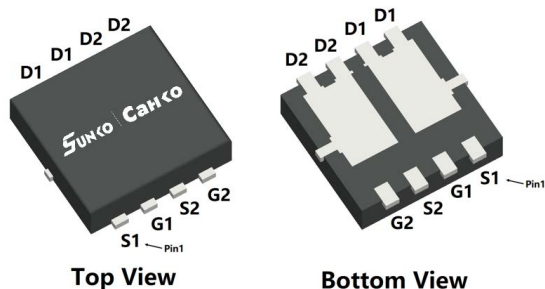
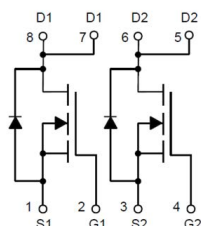


Dual N-Channel Enhancement Mode Field Effect Transistor



PDFN3333-8L
(Dual Pad)



Product Summary

• V_{DS}	30V
• I_D	40A
• $R_{DS(ON)}$ (at $V_{GS}=10V$)	<9m Ω
• $R_{DS(ON)}$ (at $V_{GS}=4.5V$)	<13m Ω

General Description

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Power Management Functions
- Analog Switch

■ Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter			Symbol	Limit	Unit
Drain-source Voltage			V _{DS}	30	V
Gate-source Voltage			V _{GS}	±20	V
Continuous Drain Current (Note 1,2)	Steady-State	T _A =25°C, V _{GS} =10V	I _D	11	A
		T _A =100°C, V _{GS} =10V		7	
Continuous Drain Current (Note 1,3)	Steady-State	T _C =25°C, V _{GS} =10V,Chip Limitation		40	
		T _C =100°C, V _{GS} =10V		25	
Pulsed Drain Current	T _C =25°C, t _p =100μs		I _{DM}	160	A
Avalanche energy	V _G =10V, R _G =25Ω, L=0.5mH, I _{AS} =11.9A		EAS	35.4	mJ
Total Power Dissipation (Note 1,2)	Steady-State	T _A =25°C	P _D	1.78	W
		T _A =100°C		0.71	
Total Power Dissipation (Note 1,3)	Steady-State	T _C =25°C		25	
		T _C =100°C		10	
Junction and Storage Temperature Range			T _J ,T _{STG}	-55~+150	°C

■ Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	Steady-State	$R_{\theta JA}$	-	70	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	-	5	

■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
SCQD9D0G03AJ	F1	9D0G03A	5000	10000	100000	13" reel

SCQD9D0G03AJ

■ Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250uA	30	-	-	V
		V _{GS} = 0V, I _D =1mA	30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
		V _{DS} =30V, V _{GS} =0V, T _j =150°C	-	-	100	
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	1.0	1.5	2.0	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =9A	-	7.1	9	mΩ
		V _{GS} =4.5V, I _D =8.5A	-	9	13	
Diode Forward Voltage	V _{SD}	I _S =9A, V _{GS} =0V	-	0.8	1.2	V
Gate resistance	R _G	f=1MHz	-	4.2	-	Ω
Maximum Body-Diode Continuous Current	I _S		-	-	22	A
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHz	-	740	-	pF
Output Capacitance	C _{oss}		-	210	-	
Reverse Transfer Capacitance	C _{rss}		-	16	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =15V, I _D =9A	-	11	-	nC
Gate-Source Charge	Q _{gs}		-	2	-	
Gate-Drain Charge	Q _{gd}		-	1.4	-	
Reverse Recovery Charge	Q _{rr}	I _F =9A, di/dt=100A/us, V _{GS} =0V, V _R =15V	-	6	-	nC
Reverse Recovery Time	t _{rr}		-	13.2	-	ns
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V, I _D =9A, R _{GEN} =3Ω	-	6.7	-	ns
Turn-on Rise Time	t _r		-	2.1	-	
Turn-off Delay Time	t _{D(off)}		-	19.4	-	
Turn-off fall Time	t _f		-	4.5	-	

Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of R_{θJA} is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with T_A =25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).

■ Typical Electrical and Thermal Characteristics Diagrams

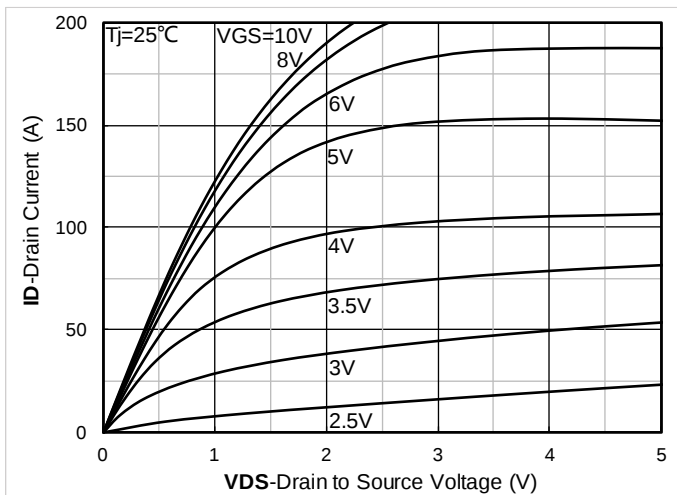


Figure 1. Output Characteristics

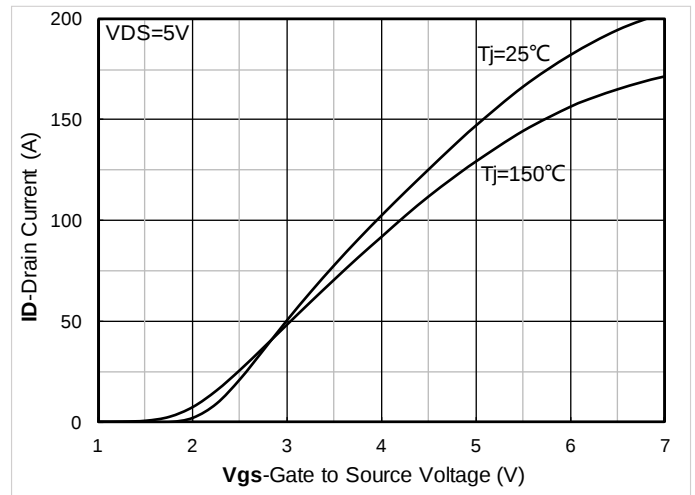


Figure 2. Transfer Characteristics

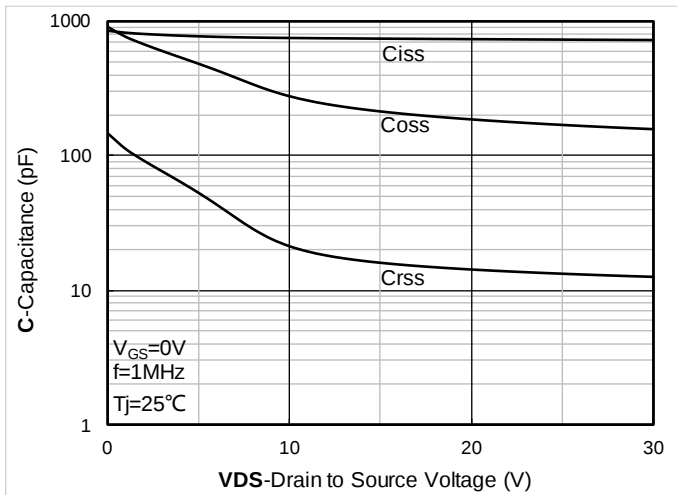


Figure 3. Capacitance Characteristics

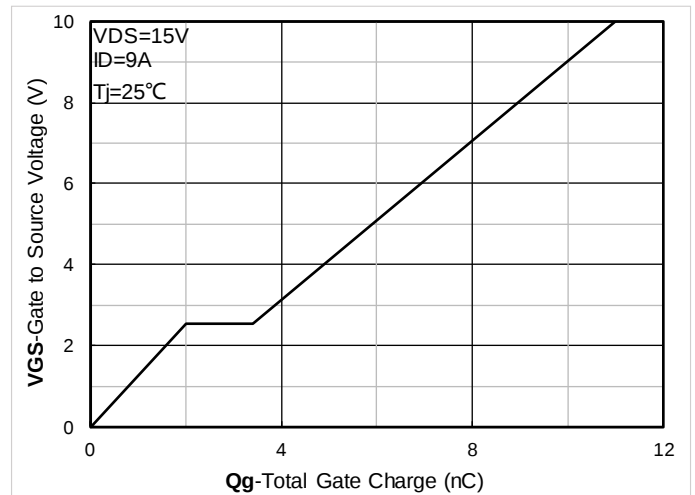


Figure 4. Gate Charge

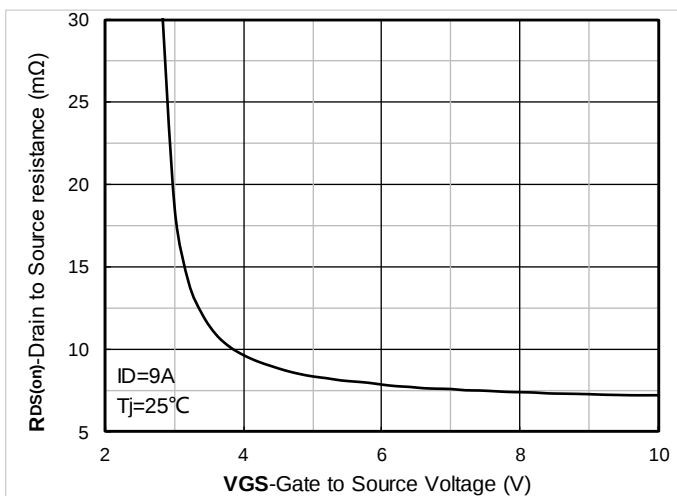


Figure 5. On-Resistance vs Gate to Source Voltage

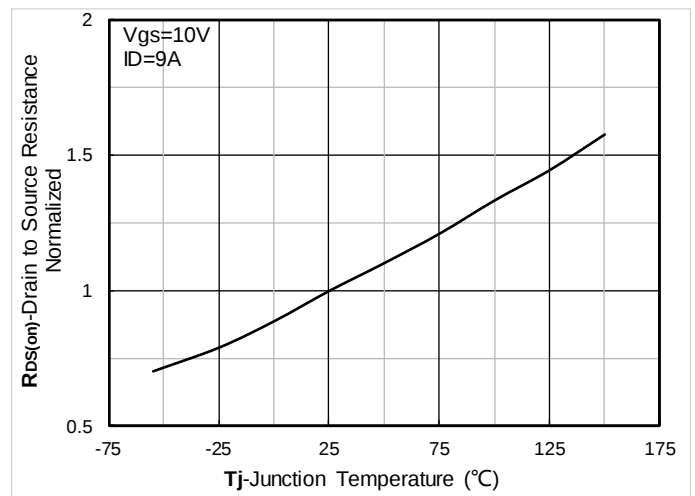


Figure 6. Normalized On-Resistance

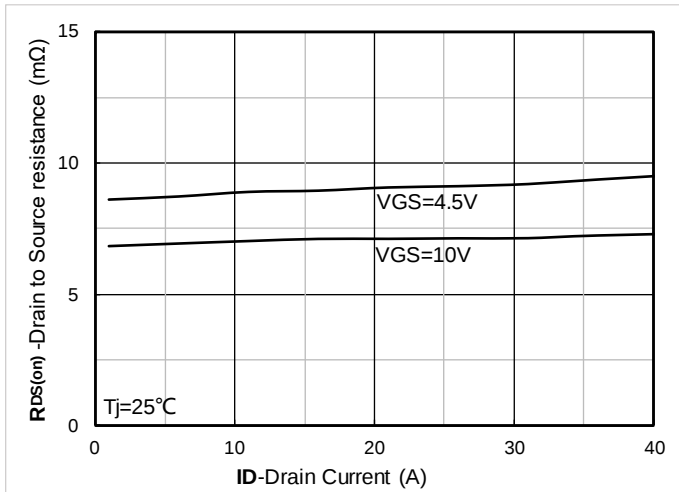


Figure 7. $R_{DS(on)}$ VS Drain Current

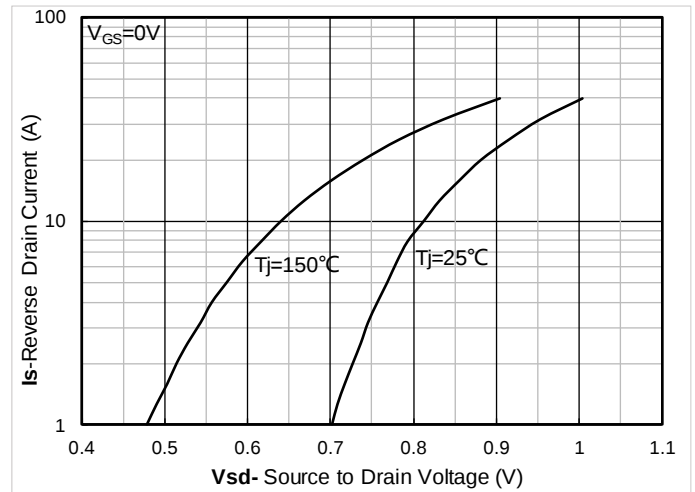


Figure 8. Forward characteristics of reverse diode

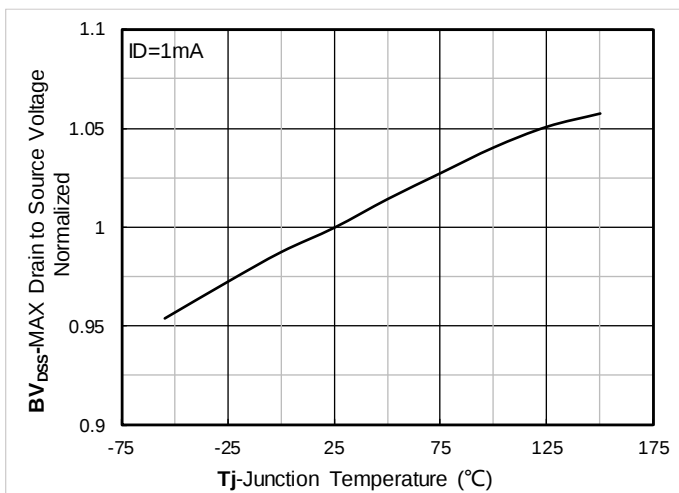


Figure 9. Normalized breakdown voltage

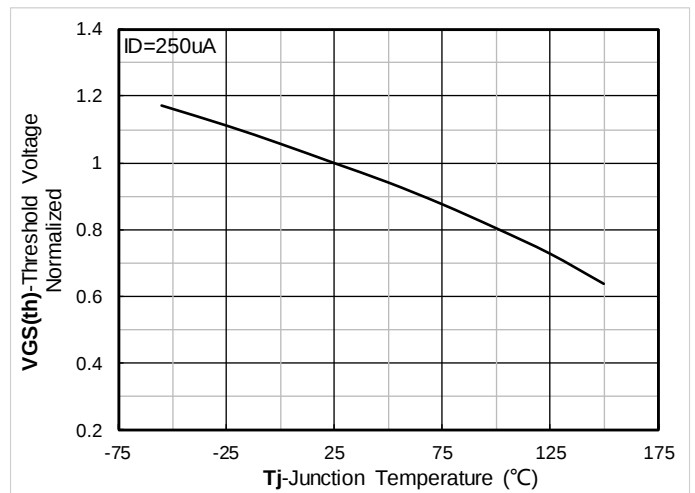


Figure 10. Normalized Threshold voltage

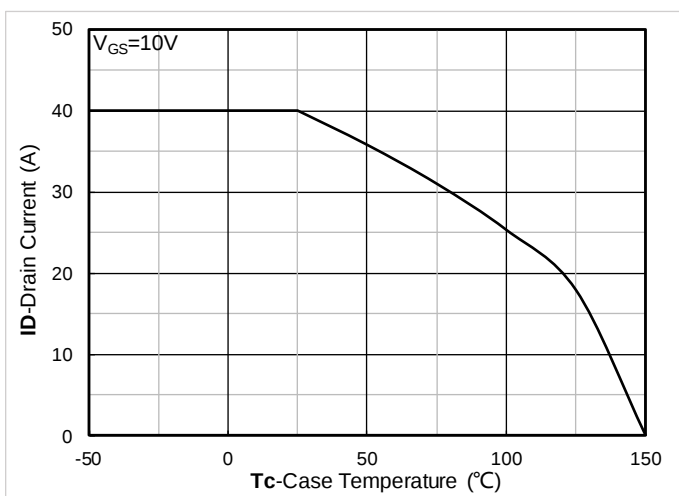


Figure 11. Current dissipation

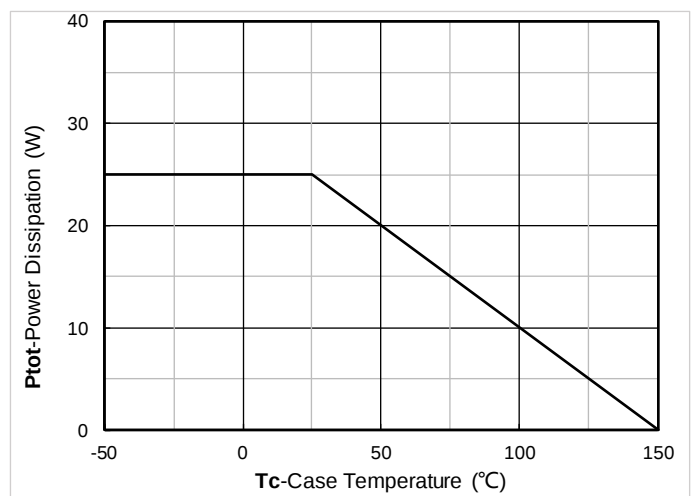


Figure 12. Power dissipation

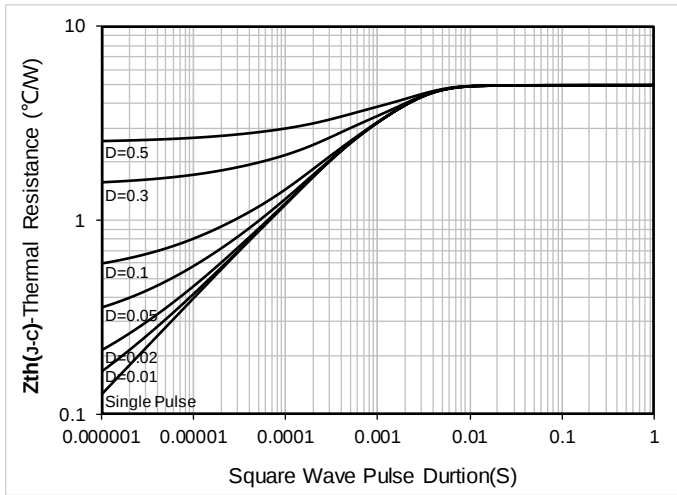


Figure 13. Maximum Transient Thermal Impedance

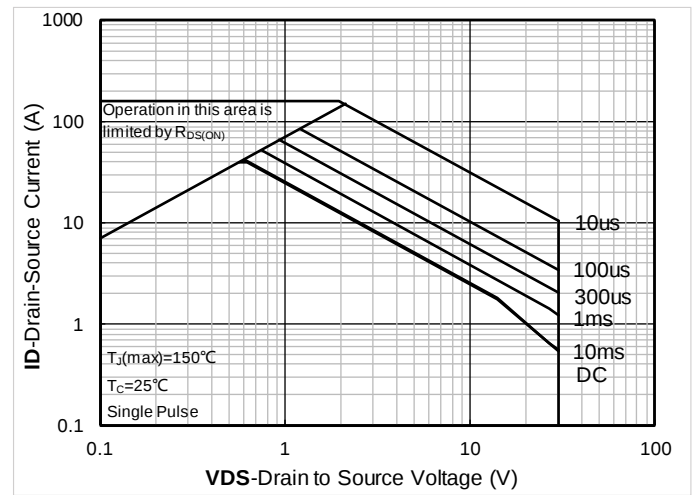


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

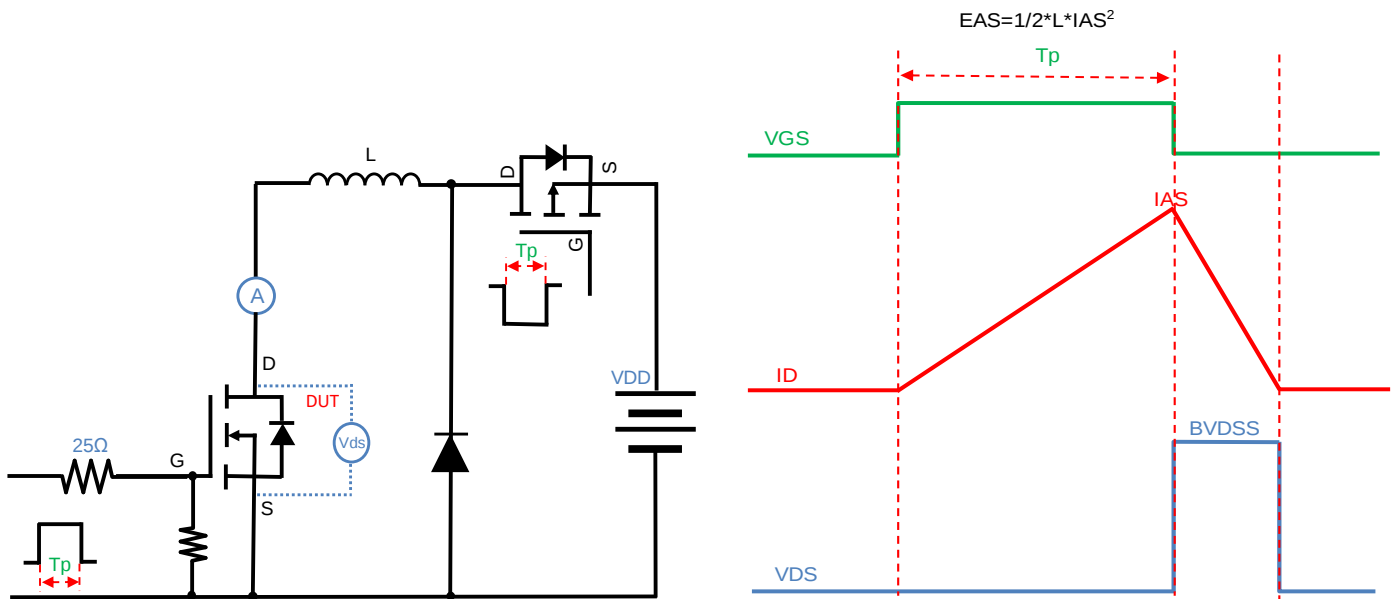


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Figure B. Gate Charge Test Circuit & Waveform



Figure C. Resistive Switching Test Circuit & Waveform

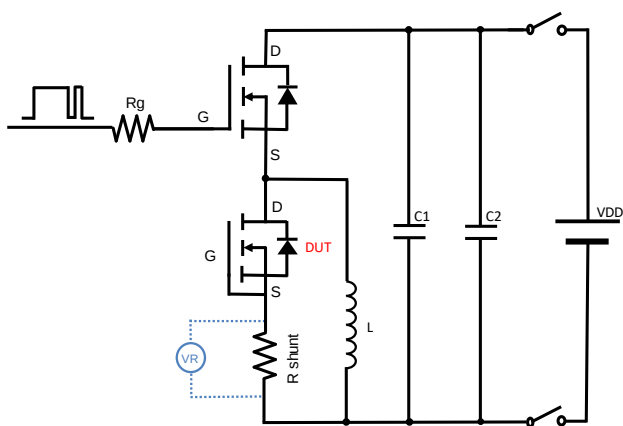
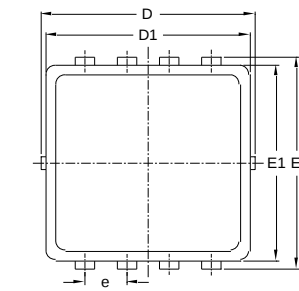
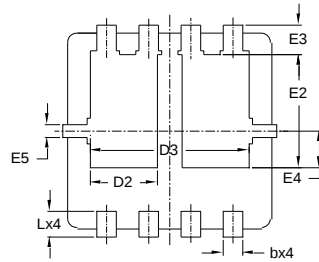


Figure D. Diode Recovery Test Circuit & Waveform

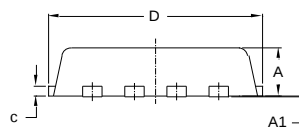
■ PDFN3333-8L-Dual Package information



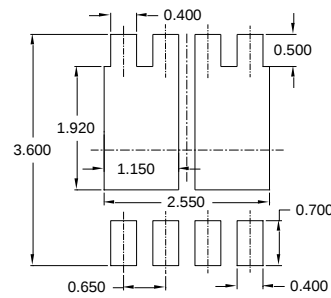
TOP VIEW



BOTTOM VIEW



SIDE VIEW



SUGGESTED SOLDER PAD LAYOUT

UNIT: mm

SYMBOL	DIMENSIONS			
	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.028	0.033	0.700	0.850
A1	0.000	0.002	0.000	0.050
b	0.008	0.016	0.200	0.400
c	0.004	0.010	0.100	0.250
D	0.124	0.136	3.150	3.450
D1	0.118	0.130	3.000	3.300
D2	0.033	0.049	0.840	1.240
D3	0.089	0.104	2.250	2.650
E	0.124	0.136	3.150	3.450
E1	0.114	0.126	2.900	3.200
E2	0.061	0.076	1.540	1.940
E3	0.011	0.026	0.280	0.650
E4	0.022 REF		0.570 REF	
E5	0.008 REF		0.200 REF	
e	0.026 BSC		0.650 BSC	
L	0.012	0.020	0.300	0.500

NOTE:

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
- 3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.

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